



# **PRODUCT DATA SHEET**



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Datasheet

ources Samples

Please note: Please check the JINGAO Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.jg-semi.cn. Please email any questions regarding the system integration to JINGAO\_questions@jgsemi.com.



### **General Description**

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

BVDSS	RDSON	ID
-20V	70m $Ω$	-3.3A

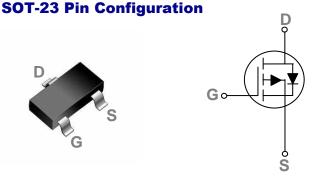
#### **Features**

- -20V, -3.3A,  $RDS(ON) = 70m\Omega@VGS = -4.5V$
- Improved dv/dt capability
- Fast switching
- Green Device Available

## **Applications**

- Notebook
- Load Switch
- Battery Protection
- Hand-held Instruments





## Absolute Maximum Ratings Tc=25℃ unless otherwise noted

Symbol	Parameter	Rating	Units
$V_{DS}$	Drain-Source Voltage	-20	V
V <sub>GS</sub>	Gate-Source Voltage	±12	V
	Drain Current – Continuous (T <sub>C</sub> =25°C)	-3.3	А
D	Drain Current – Continuous (T <sub>C</sub> =100°C)	-2.1	А
DM	Drain Current – Pulsed <sup>1</sup>	-13.2	А
2	Power Dissipation (T <sub>C</sub> =25°C)	1.56	W
D <sub>D</sub>	Power Dissipation – Derate above 25°C	0.012	W/°C
$\Gamma_{ m STG}$	Storage Temperature Range	-55 to 150	°C
Γ <sub>J</sub>	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Characteristics**

Symbol	Symbol Parameter		Max.	Unit
$R_{\theta JA}$	Thermal Resistance Junction to ambient		80	°C/W



## **Electrical Characteristics** (T<sub>J</sub>=25 °C, unless otherwise noted)

### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250uA				V
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient	Reference to 25°C , I <sub>D</sub> =-1mA		-0.01		V/°C
I <sub>DSS</sub>	Drain Source Leakage Current	$V_{DS}$ =-20V , $V_{GS}$ =0V , $T_J$ =25 $^{\circ}$ C			-1	uA
	Drain-Source Leakage Current	V <sub>DS</sub> =-16V , V <sub>GS</sub> =0V , T <sub>J</sub> =125°C			-10	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}=\pm 12V$ , $V_{DS}=0V$			±10	uA

#### **On Characteristics**

R <sub>DS(ON)</sub> Static Drain-Source	Static Drain-Source On-Resistance	$V_{GS}$ =-4.5 $V$ , $I_D$ =-3 $A$		70	85	mΩ
	Chaire Drawn Course Chi Nooisianse	V <sub>GS</sub> =-2.5V , I <sub>D</sub> =-2A		95	120	11122
$V_{GS(th)}$	Gate Threshold Voltage	V V I 050A	-0.3	-0.6	-1.0	V
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$V_{GS}=V_{DS}$ , $I_D$ =-250uA		3		mV/°C
gfs	Forward Transconductance	V <sub>DS</sub> =-10V , I <sub>S</sub> =-1A		2.2		S

## **Dynamic and switching Characteristics**

Qg	Total Gate Charge <sup>2,3</sup>			4.8	
$Q_gs$	Gate-Source Charge <sup>2, 3</sup>	$V_{DS}$ =-10V , $V_{GS}$ =-4.5V , $I_{D}$ =-3A		0.5	nC
$Q_gd$	Gate-Drain Charge <sup>2, 3</sup>			1.9	
$T_{d(on)}$	Turn-On Delay Time <sup>2,3</sup>			3.5	
Tr	Rise Time <sup>2,3</sup>	$V_{DD}$ =-10V , $V_{GS}$ =-4.5V , $R_{G}$ =25 $\Omega$		12.6	nS
$T_{d(off)}$	Turn-Off Delay Time <sup>2,3</sup>	I <sub>D</sub> =-1A	-	32.6	113
T <sub>f</sub>	Fall Time <sup>2, 3</sup>			8.4	
C <sub>iss</sub>	Input Capacitance		-	350	
Coss	Output Capacitance	$V_{DS}$ =-15V , $V_{GS}$ =0V , F=1MHz		65	pF
C <sub>rss</sub>	Reverse Transfer Capacitance			50	

## **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter	Conditions		Тур.	Max.	Unit
Is	Continuous Source Current	VV0V Force Current			-3.3	Α
I <sub>SM</sub>	Pulsed Source Current	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-13.2	Α
$V_{SD}$	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A , T <sub>J</sub> =25°C			-1.2	V

#### Note:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- The data tested by pulsed , pulse width ≤ 300us , duty cycle ≤ 2%.
   Essentially independent of operating temperature.



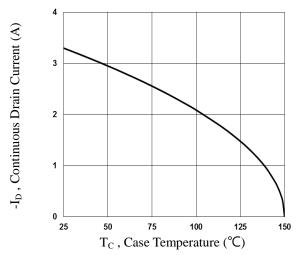


Fig.1 Continuous Drain Current vs. Tc

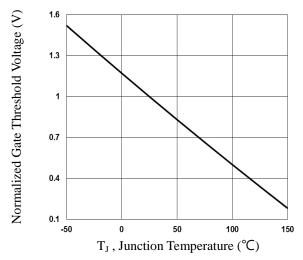


Fig.3 Normalized V<sub>th</sub> vs. T<sub>J</sub>

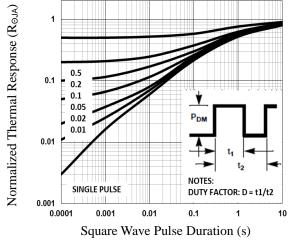


Fig.5 Normalized Transient Response

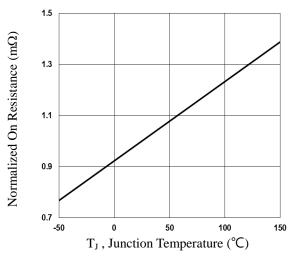


Fig.2 Normalized RDSON vs. T<sub>J</sub>

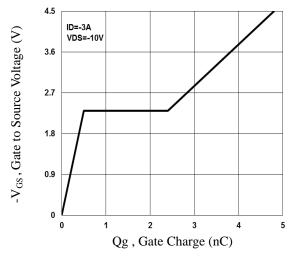


Fig.4 Gate Charge Waveform

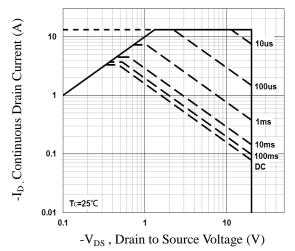
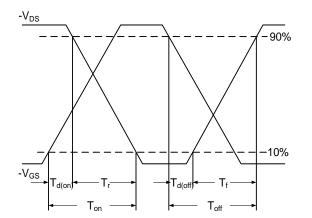


Fig.6 Maximum Safe Operation Area







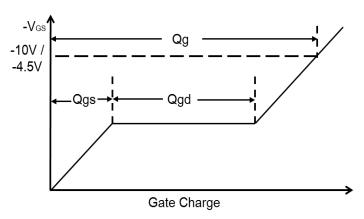
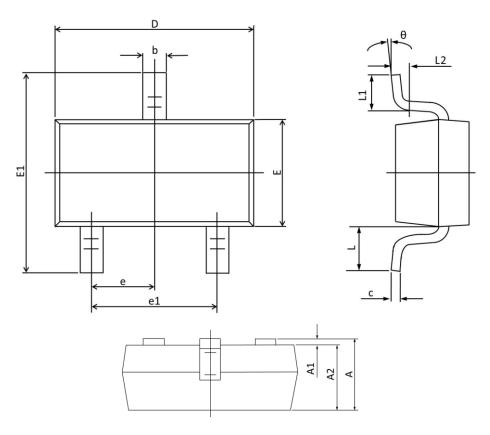


Fig.8 Gate Charge Waveform



# **SOT-23 PACKAGE INFORMATION**



Cruss b ol	Dimensions I	n Millimeters	Dimension	s In Inches	
Symbol	Max	Min	Max	Min	
A	1.150	0.900	0.045	0.035	
A1	0.100	0.000	0.004	0.000	
A2	1.050	0.900	0.041	0.035	
b	0.500	0.300	0.020	0.012	
c	0.150	0.080	0.006	0.003	
D	3.000	2.800	0.118	0.110	
E	1.400	1.200	0.055	0.047	
<b>E</b> 1	2.550	2.250	0.100	0.089	
e	0.95 TYP.		0.03	7 TYP.	
e1	2.000	1.800	0.079	0.071	
L	0.55	REF.	0.022	2 REF.	
L1	0.500	0.300	0.020	0.012	
L2	0.25	TYP.	0.01 TYP.		
θ	<b>8</b> °	<b>0</b> °	<b>8</b> °	<b>0</b> °	



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